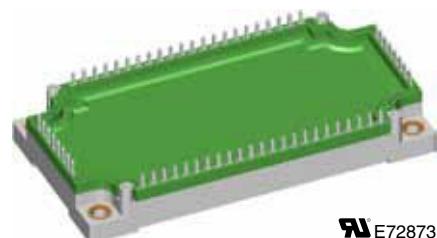
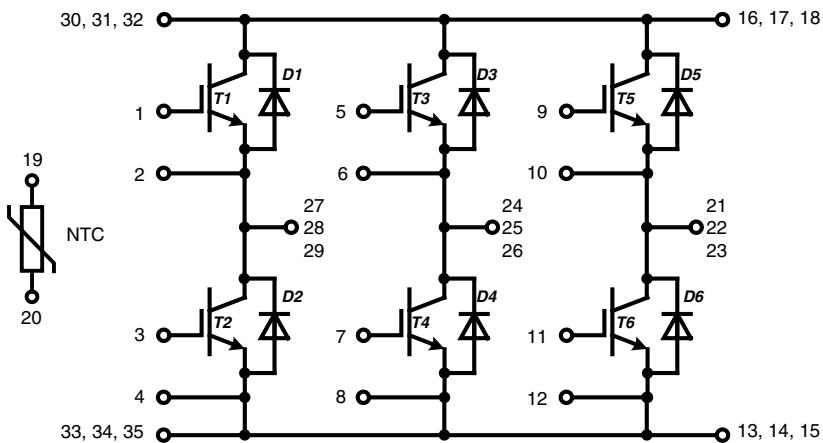


Six-Pack XPT IGBT

$V_{CES} = 1200\text{ V}$
 $I_{C25} = 220\text{ A}$
 $V_{CE(sat)} = 1.8\text{ V}$

Part name (Marking on product)

MIXA150W1200TEH



E72873

Pin configuration see outlines.

Features:

- Easy paralleling due to the positive temperature coefficient of the on-state voltage
- Rugged XPT design (Xtreme light Punch Through) results in:
 - short circuit rated for 10 μsec .
 - very low gate charge
 - square RBSOA @ 3x I_C
 - low EMI
- Thin wafer technology combined with the XPT design results in a competitive low $V_{CE(sat)}$
- SONIC™ diode
 - fast and soft reverse recovery
 - low operating forward voltage

Application:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies

Package:

- "E3-Pack" standard outline
- Insulated copper base plate
- Soldering pins for PCB mounting
- Temperature sense included
- Optimizes pin layout

Output Inverter T1 - T6

Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{CES}	collector emitter voltage	$T_{VJ} = 25^\circ C$		1200		V
V_{GES}	max. DC gate voltage	continuous		± 20		V
V_{GEM}	max. transient collector gate voltage	transient		± 30		V
I_{C25}	collector current	$T_C = 25^\circ C$	220			A
I_{C80}		$T_C = 80^\circ C$	150			A
P_{tot}	total power dissipation	$T_C = 25^\circ C$	695			W
$V_{CE(sat)}$	collector emitter saturation voltage	$I_C = 150 A; V_{GE} = 15 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1.8 2.1	2.1	V
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 6 mA; V_{GE} = V_{CE}$	$T_{VJ} = 25^\circ C$	5.4	6.0	V
I_{CES}	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	0.05 1.0	0.5	mA
I_{GES}	gate emitter leakage current	$V_{GE} = \pm 20 V$		500		nA
$Q_{G(on)}$	total gate charge	$V_{CE} = 600 V; V_{GE} = 15 V; I_C = 150 A$		470		nC
$t_{d(on)}$	turn-on delay time	$T_{VJ} = 125^\circ C$ $V_{CE} = 600 V; I_C = 150 A$ $V_{GE} = \pm 15 V; R_G = 4.7 \Omega$	70			ns
t_r	current rise time		40			ns
$t_{d(off)}$	turn-off delay time		250			ns
t_f	current fall time		100			ns
E_{on}	turn-on energy per pulse		14			mJ
E_{off}	turn-off energy per pulse		16			mJ
E_{rec}	diode turn-off energy per pulse		10			mJ
RBSOA	reverse bias safe operating area	$V_{GE} = \pm 15 V; R_G = 4.7 \Omega;$ $V_{CEK} = 1200 V$		450		A
SCSOA	short circuit safe operating area					
t_{sc}	short circuit duration	$T_{VJ} = 125^\circ C$ $V_{CE} = 900 V; V_{GE} = \pm 15 V;$ $R_G = 4.7 \Omega$; non-repetitive		10		μs
I_{sc}	short circuit current		600			A
R_{thJC}	thermal resistance junction to case	(per IGBT)		0.18		K/W

Output Inverter D1 - D6

Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 25^\circ C$		1200		V
I_{F25}	forward current	$T_C = 25^\circ C$		190		A
I_{F80}		$T_C = 80^\circ C$		130		A
V_F	forward voltage	$I_F = 150 A; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1.95 1.95	2.2	V
Q_{rr}	reverse recovery charge	$T_{VJ} = 125^\circ C$ $V_R = 600 V$ $di_F/dt = -2500 A/\mu s$ $I_F = 150 A; V_{GE} = 0 V$	20			μC
I_{RM}	max. reverse recovery current		175			A
t_{rr}	reverse recovery time		350			ns
E_{rec}	reverse recovery energy		10			mJ
R_{thJC}	thermal resistance junction to case	(per diode)		0.28		K/W

 $T_C = 25^\circ C$ unless otherwise stated

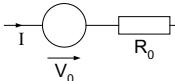
Temperature Sensor NTC

Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
R_{25}	<i>resistance</i>		$T_c = 25^\circ C$	4.75	5.0	$k\Omega$
$B_{25/50}$				3375	5.25	K

Module

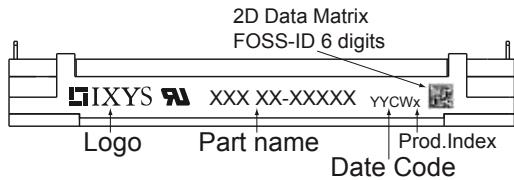
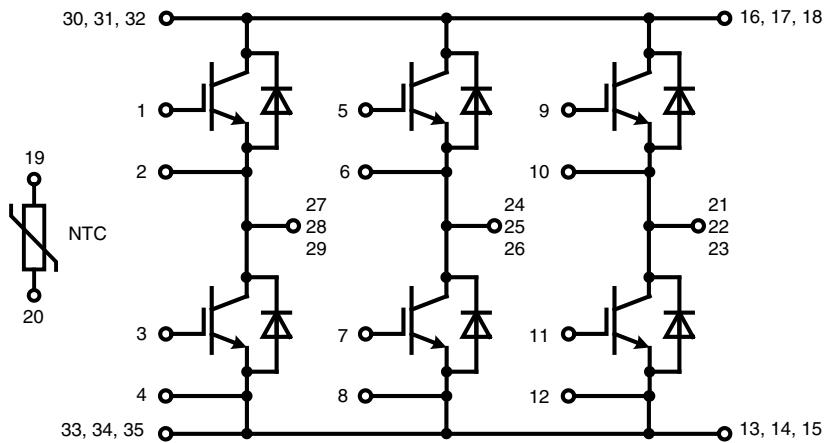
Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
T_{VJ}	<i>operating temperature</i>		-40		125	$^\circ C$
T_{VJM}	<i>max. virtual junction temperature</i>				150	$^\circ C$
T_{stg}	<i>storage temperature</i>		-40		125	$^\circ C$
V_{ISOL}	<i>isolation voltage</i>	$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$			3000	V~
CTI	<i>comparative tracking index</i>				200	
M_d	<i>mounting torque (M5)</i>		3		6	Nm
d_s	<i>creep distance on surface</i>		10			mm
d_A	<i>strike distance through air</i>		7.5			mm
$R_{pin-chip}$	<i>resistance pin to chip</i>			2.5		$m\Omega$
R_{thCH}	<i>thermal resistance case to heatsink</i>	with heatsink compound		0.02		K/W
Weight				300		g

Equivalent Circuits for Simulation



Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_0	<i>IGBT</i>	$T1 - T6$	$T_{VJ} = 150^\circ C$		1.1	V
R_0					9.2	$m\Omega$
V_0	<i>free wheeling diode</i>	$D1 - D6$	$T_{VJ} = 150^\circ C$		1.25	V
R_0					5.7	$m\Omega$

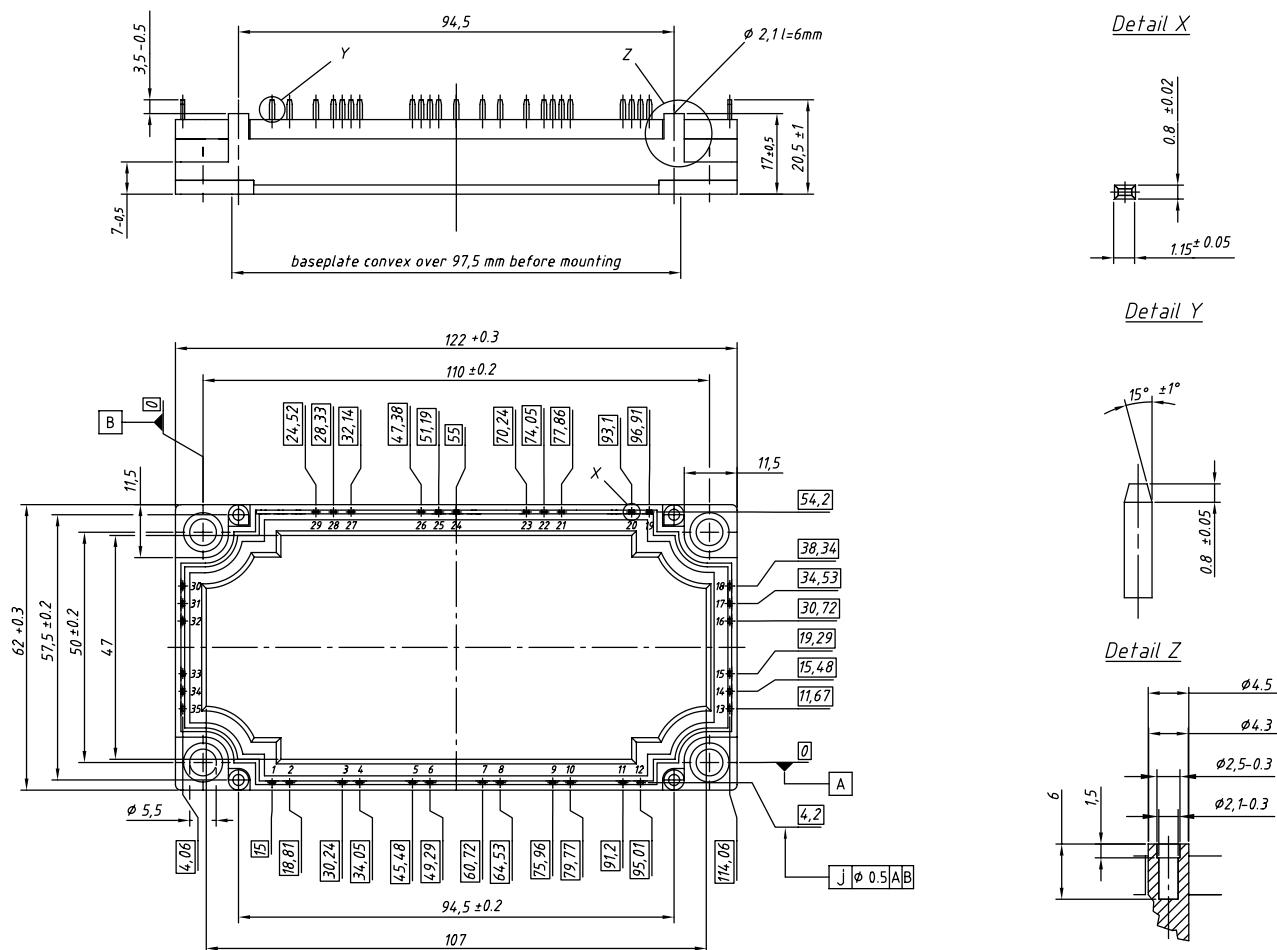
 $T_c = 25^\circ C$ unless otherwise stated

Circuit Diagram**Part number**

M = Module
I = IGBT
X = XPT
A = standard
150 = Current Rating [A]
W = Six-Pack
1200 = Reverse Voltage [V]
T = NTC
EH = E3-Pack

Outline Drawing

Dimensions in mm (1 mm = 0.0394")

**Product Marking**

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MIXA150W1200 TEH	MIXA150W1200TEH	Box	5	509654

Transistor T1 - T6

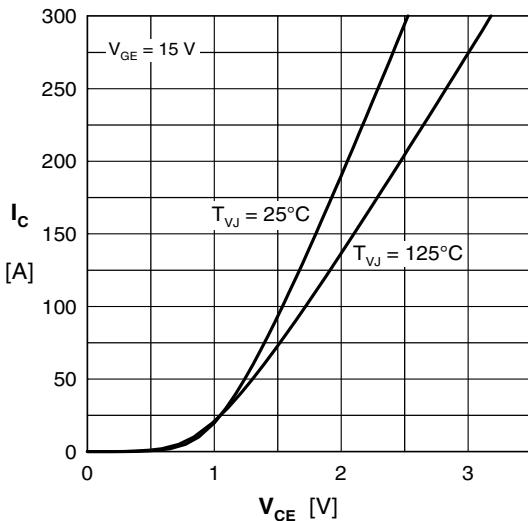


Fig. 1 Typ. output characteristics

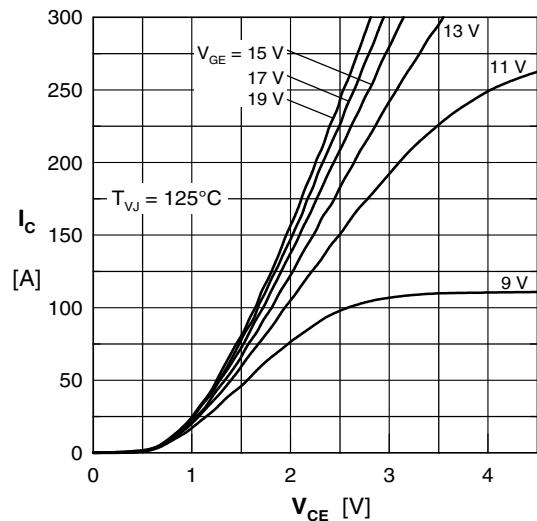


Fig. 2 Typ. output characteristics

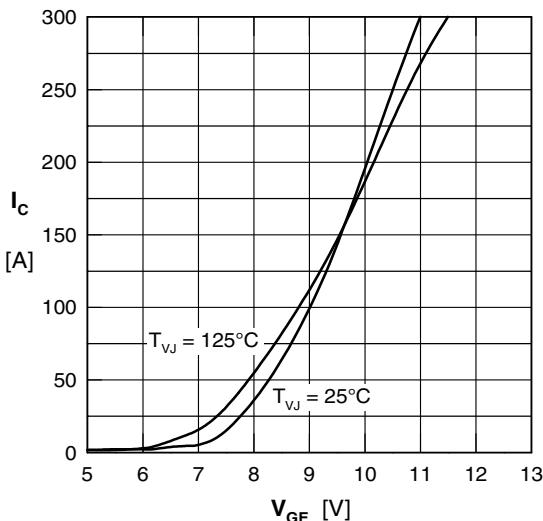


Fig. 3 Typ. tranfer characteristics

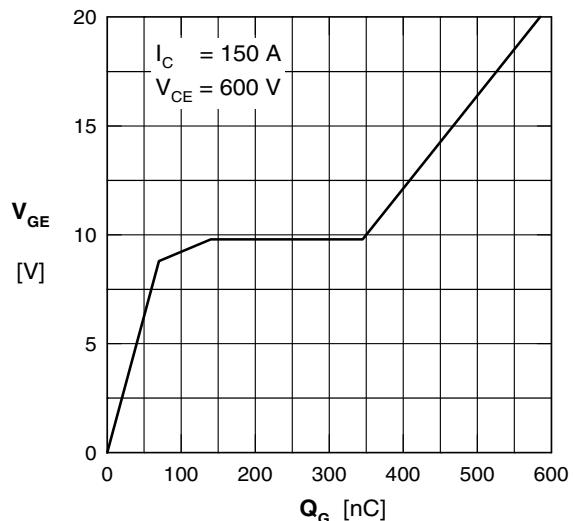


Fig. 4 Typ. turn-on gate charge

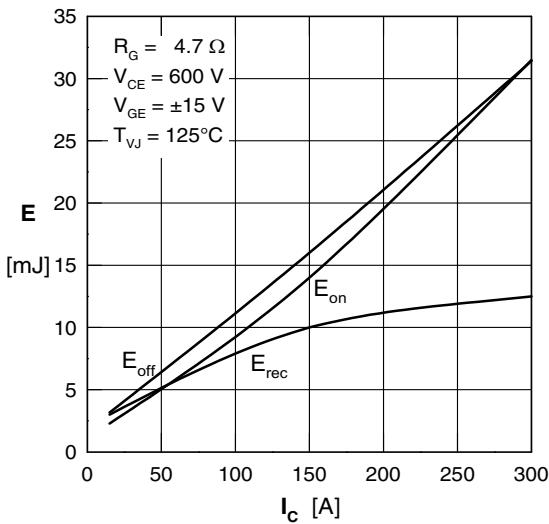


Fig. 5 Typ. switching energy vs. collector current

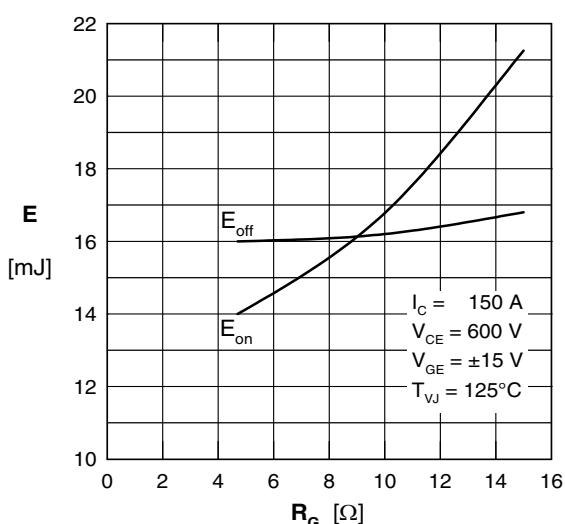


Fig. 6 Typ. switching energy vs. gate resistance

IXYS reserves the right to change limits, test conditions and dimensions.

20110510b

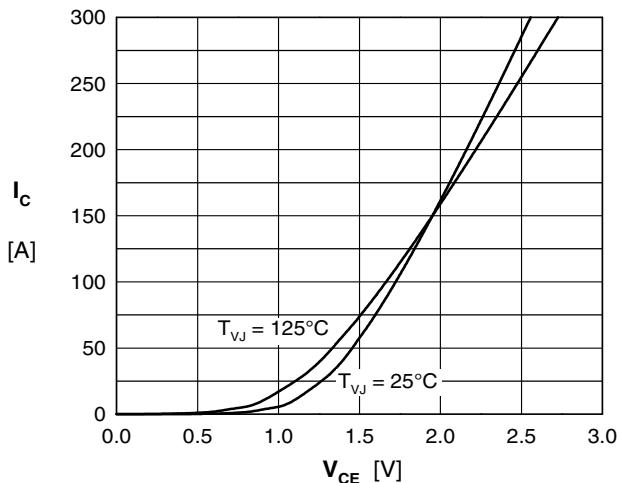
Inverter D1 - D6


Fig. 7 Typical forward characteristics

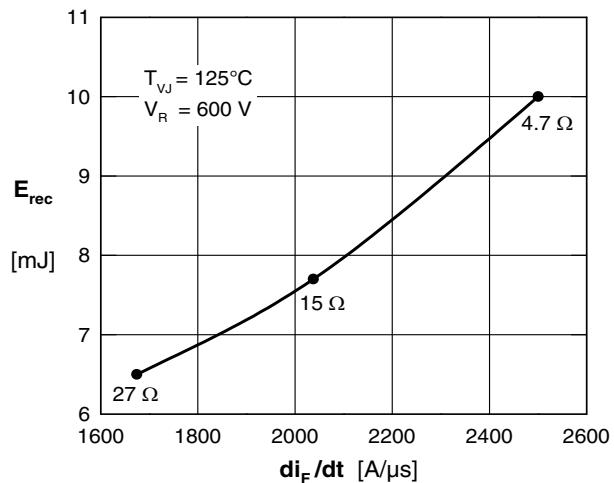
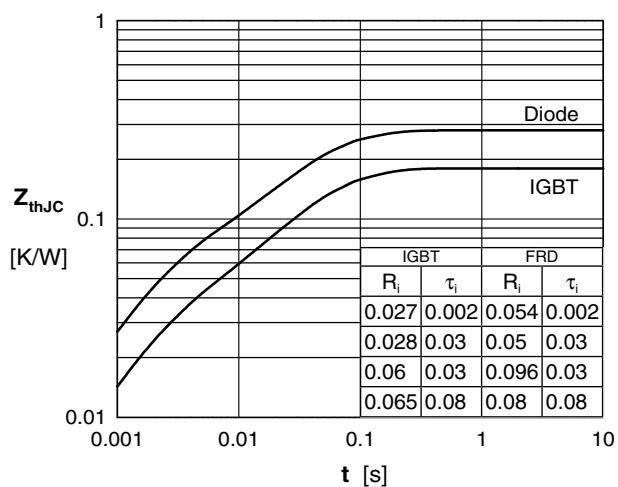
Inverter Transistor & Diode

 Fig. 8 Typ. recovery energy E_{rec} versus di_F/dt
NTC


Fig. 9 Typ. transient thermal impedance

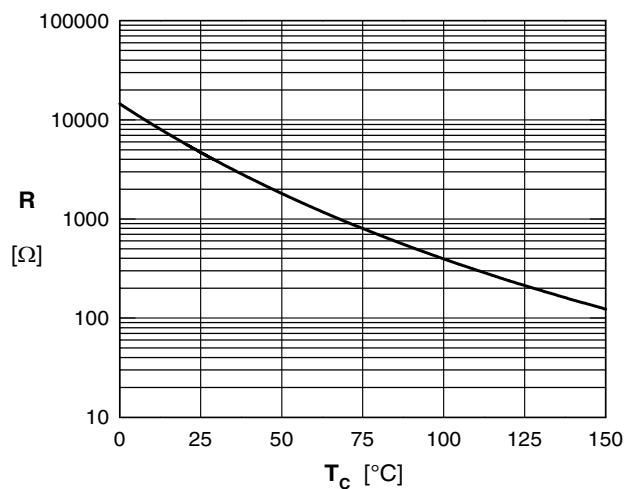


Fig. 10 Typ. NTC resistance vs. temperature